

Search Notes

Application/Control No.

10/509,393

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

STUDER, CHRISTOPH

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
174	113R	7/23/2005	LEE
↓	110R	↓	↓
↓	115	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
174	as above	7/23/2005	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search Attached	7/23/2005	LEE